

SHIGA7.014APC

PATENT

IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

Applicant : TAKESHITA, et al.) Group Art Unit Unknown
Int'l App. No. : PCT/JP03/16267)
Int'l Filing Date : December 18, 2003)
For : RESIST COMPOSITION AND)
METHOD OF FORMING RESIST)
PATTERN USING SAME)
Examiner : Unknown)

INFORMATION DISCLOSURE STATEMENT

Commissioner for Patents
P.O. Box 1450
Alexandria, VA 22313-1450

Dear Sir:

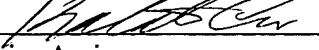
Enclosed is form PTO/SB/08 Equivalent listing references that are also enclosed. As indicated in the accompanying Form PCT/ISA/210, the document Nos. US 6,340,553 B1, US 2002/0102492 A1, EP 1 033 624 A1 and EP 1 020 767 A1 were cited in the International Search Report in the international phase of the present U.S. national phase application. Although the listed references are already of record during the International Phase of the application, they are submitted in the present Information Disclosure Statement for the convenience of the Examiner and to ensure that the references are listed on the cover of any patent issued on the present application.

Document Nos. JP 2002-201232, JP 2002-278069 and JP 2002-278071 are not cited during the International Phase, but they are disclosed in the present specification.

This Information Disclosure Statement is being filed within three months of the date of entry of the national stage of this application, and no fee is required in accordance with 37 C.F.R. § 1.97(b)(2).

Respectfully submitted,
KNOBBE, MARTENS, OLSON & BEAR, LLP

Dated: April 19, 2005

By: 
Katsuhiro Arai
Registration No. 43,315
Customer No. 20,995
(949) 760-0404

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INFORMATION DISCLOSURE STATEMENT BY APPLICANT <i>(Multiple sheets used when necessary)</i>	Int'l Application No.	PCT/JP03/16267
	Int'l Filing Date	December 18, 2003
	First Named Inventor	Masaru TAKESHITA
	Art Unit	Unknown
Examiner		Unknown
SHEET 1 OF 1	Attorney Docket No.	SHIGA7.014APC

U.S. PATENT DOCUMENTS					
Examiner Initials	Cite No.	Document Number Number - Kind Code (if known) Example: 1,234,567 B1	Publication Date MM-DD-YYYY	Name of Patentee or Applicant	Pages, Columns, Lines Where Relevant Passages or Relevant Figures Appear
	1.	6,340,553 B1	01/22/02	Oomori, et al.	
	2.	2002/0102492 A1	08/01/02	Iwai, et al.	

FOREIGN PATENT DOCUMENTS						
Examiner Initials	Cite No.	Foreign Patent Document Country Code-Number-Kind Code Example: JP 1234567 A1	Publication Date MM-DD-YYYY	Name of Patentee or Applicant	Pages, Columns, Lines Where Relevant Passages or Relevant Figures Appear	T ¹
	3.	JP 2002-201232	07/19/02	Daicel Chem Ind Ltd	(English Abstract Only)	X
	4.	JP 2002-278069	09/27/02	Sumitomo Chem Co Ltd.	(English Abstract Only)	X
	5.	JP 2002-278071	09/27/02	Fuji Photo Film Co Ltd., FujiFilm Arch Co Ltd.	(English Abstract Only)	X
	6.	EP 1 020 767 A1	07/19/00	Sumitomo Chemical Co Ltd		
	7.	EP 1 033 624 A1	09/06/00	Clariant International Ltd.		

NON PATENT LITERATURE DOCUMENTS			
Examiner Initials	Cite No.	Include name of the author (in CAPITAL LETTERS), title of the article (when appropriate), title of the item (book, magazine, journal, serial, symposium, catalog, etc.), date, page(s), volume-issue number(s), publisher, city and/or country where published.	T ¹

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Examiner Signature	Date Considered
*Examiner: Initial if reference considered, whether or not citation is in conformance with MPEP 609. Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.	

T¹ - Place a check mark in this area when an English language Translation is attached.